


<b>Search Notes</b>  	<b>Application/Control No.</b>  10521490	<b>Applicant(s)/Patent Under Reexamination</b>  SAITOU ET AL.
	<b>Examiner</b>  Hsieh, Ping Y.	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	550.1, 562.1, 575.1, 575.3, 575.5, 575.7, 90.3	8/29/09	PH

SEARCH NOTES		
Search Notes	Date	Examiner
Text search in EAST (see search history)	8/29/09	PH
Consulted with Yuwen Pan	4/9/09	PH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/P. Y. H./  
Examiner, Art Unit 2618